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EXAMINER

GRAYBILL, DAVID E

ART UNIT

PAPER NUMBER

2827

DATE MAILED: 10/02/2002

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/963,590

Applicant(s)

KOMIYAMA ET AL.

Examiner

David E Graybill

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 08 February 2002.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-28 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-28 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☐ The proposed drawing correction filed on _____ is: a) ☐ approved b) ☐ disapproved by the Examiner.
If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

- 13) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☒ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☒ Information Disclosure Statement(s) (PTO-1449) Paper No(s) 9.
- 4) ☐ Interview Summary (PTO-413) Paper No(s). _____.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____.

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A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after allowance or after an Office action under *Ex Parte Quayle*, 25 USPQ 74, 453 O.G. 213 (Comm'r Pat. 1935). Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, prosecution in this application has been reopened pursuant to 37 CFR 1.114. Applicant's submission filed on 6-17-2 has been entered.

The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

Claims 11 and 12 are rejected under 35 U.S.C. 112, first paragraph, as containing subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention. The non-described subject matter is the claim 11 limitation, wherein the first area is not physically connected to the first bond of the third bonding wire, and the claim 12 limitation, wherein the second area is not physically connected

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to the first bond of the second bonding wire. To further clarify, the first and second areas are originally disclosed as being physically connected to the first bonds at least via the conductive relay pad.

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 3-12, 17, 18 and 26 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claims 3, 4, 17 and 18 the limitation "the beginning connection" is unclear because the limitation refers to a "beginning connection" but there is no apparent previous claim-recitation of a beginning connection.

In claims 3, 4, 17 and 18 the limitation "the second bond" is unclear because the limitation refers to a "second bond" but there is no apparent previous claim-recitation of a second bond.

In claims 3, 4, 17 and 18 the limitation "the ending connection" is unclear because the limitation refers to an "ending connection" but there is no apparent previous claim-recitation of an ending connection.

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In claims 3, 4, 11, 12, 17 and 18 the limitation "the first bond" is unclear because the limitation refers to a "first bond" but there is no apparent previous claim-recitation of a first bond.

In claims 5, 6, 8 and 9 the limitation "the periphery" is unclear because the limitation refers to a "periphery" but there is no apparent previous claim-recitation of a periphery.

In claims 5-10 and 26 the limitation "the side of the first semiconductor chip" is unclear because the limitation refers to a "side of the first semiconductor chip" but there is no apparent previous claim-recitation of a side of the first semiconductor chip.

In claims 5 and 8 the limitation "the longer side" is unclear because the limitation refers to a "longer side" but there is no apparent previous claim-recitation of a longer side.

In claims 6 and 9 the limitation "the shorter side" is unclear because the limitation refers to a "shorter side" but there is no apparent previous claim-recitation of a shorter side.

In the rejections infra, reference labels are generally recited only for the first recitation of identical claim language.

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The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35

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U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

Claims 13, 14, 19-23, 25, 26 and 28 are rejected under 35 U.S.C. 102(b) as being anticipated by Takiar (5422435).

At column 4, line 42 to column 8, line 51, Takiar teaches the following:

13. A multi-chip package type semiconductor device, comprising: a first semiconductor chip 22 having a first terminal pad 32 and a conductive relay pad 58, the conductive relay pad including a first area and a second area, a second semiconductor chip 24, which is placed on the first semiconductor chip, the second semiconductor chip having a second terminal pad 54, connected to the conductive relay pad in the second area; a first internal terminal 46 connected to the first terminal pad; and a second internal terminal 44 connected to the conductive relay pad in the first area.

14. A multi-chip package type semiconductor device, as in 13, further comprising an insulating substrate "carrier member", wherein the first and second internal terminals are formed on the insulating substrate, and the first semiconductor chip is placed on the insulating substrate.

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19. A multi-chip package type semiconductor device, as in 13, wherein the first area and the second area are located along a side of the first semiconductor chip.

20. A multi-chip package type semiconductor device, comprising: a first semiconductor chip having a first conductive portion 32 and a second conductive portion 58, the second conductive portion having a first area and a second area; a second semiconductor chip, which is placed on the first semiconductor chip, the second semiconductor chip having a third conductive portion, connected to the second conductive portion in the first area; a first internal terminal connected to the first conductive portion; and a second internal terminal connected to the second conductive portion in the second area.

21. A multi-chip package type semiconductor device, as in 20, wherein the first area and the second area are located along a side of the first semiconductor chip.

22. A multi-chip package type semiconductor device, as in 20, further comprising an insulating substrate, wherein the first and second internal terminals are formed on the insulating substrate, and the first semiconductor chip is placed on the insulating substrate.

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23. A multi-chip package type semiconductor device, as in 20, wherein the first area and the second area are spaced from each other.

25. A multi-chip package type semiconductor device, comprising: an insulating substrate; a first conductive pattern formed on the insulating substrate; a first semiconductor chip mounted on the insulating substrate; a second conductive pattern 58 formed on the first semiconductor chip, the second conductive pattern having a first area and a second area; a second semiconductor chip mounted on the first semiconductor chip; a third conductive pattern 54 formed on the second semiconductor chip; a first wire 56 connected between the first area of the second conductive pattern and the third conductive pattern; and a second wire 60 connected between the second area of the second conductive pattern and the first conductive pattern.

26. A multi-chip package type semiconductor device, as in 25, wherein the first area and the second area are located along the side of the first semiconductor chip.

28. A multi-chip package type semiconductor device, as in 25, wherein the first area and the second area are spaced each other.

Claims 1, 2, 15 and 16 are rejected under 35 U.S.C. 102(b) as anticipated by or, in the alternative, under 35 U.S.C. 103(a)

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as obvious over Takiar (5422435), or further in the alternative, under 35 U.S.C. 103(a) as obvious over the combination of Takiar (5422435) and Haba (6376904).

As cited supra, Takiar teaches the following:

1. A multi-chip package type semiconductor device, comprising: an insulating substrate having thereon a first conductive pattern 46 and a second conductive pattern 44; a first semiconductor chip having a first internal circuit on the insulating substrate, the first semiconductor chip having a first terminal pad connecting to the first internal circuit and a conductive relay pad isolated from the first terminal pad, and the conductive relay pad including a first area and a second area; a second semiconductor chip on the first semiconductor chip, the second semiconductor chip being smaller than the first semiconductor chip, and having a second internal circuit and having a second terminal pad connecting to the second internal circuit; a first bonding wire [not labeled] connecting the first terminal pad to the first conductive pattern; a second bonding wire 60 connecting the second conductive pattern to the conductive relay pad in the first area; and a third bonding wire 56 connecting the conductive relay pad in the second area to the second terminal pad; wherein the lengths of the first, second and third bonding wire are approximately the same.

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2. A multi-chip package type semiconductor device, as in 1, wherein the second semiconductor chip is placed on the center of the first semiconductor chip.

15. A multi-chip package type semiconductor device, comprising: an insulating substrate having a first and second conductive patterns thereon; a first semiconductor chip on the insulating substrate, the first semiconductor chip having a first internal circuit, a first terminal pad connecting to the first internal circuit and a conductive relay pad isolated from the first terminal pad; a second semiconductor chip on the first semiconductor chip, the second semiconductor chip being smaller than the first semiconductor chip, and having a second internal circuit and having a second terminal pad connecting to the second internal circuit, a first bonding wire connecting the first terminal pad to the first conductive pattern; a second bonding wire connecting the second conductive pattern to the conductive relay pad; and a third bonding wire connecting the conductive relay pad to the second terminal pad; wherein the lengths of the first, second and third bonding wire are approximately the same.

16. A multi-chip package type semiconductor device, as in 15, wherein the second semiconductor chip is placed on the center of the first semiconductor chip.

To further clarify the teaching wherein the lengths of the first, second and third bonding wire are approximately the same, as cited, Takiar teaches "short wire bond lengths," and "wire bond lengths meeting standard assembly specifications." Therefore, Takiar teaches that the lengths of the wires are the same short standard assembly length.

In any case, in the alternative, it would have been an obvious matter of design choice bounded by well known manufacturing constraints and ascertainable by routine experimentation and optimization to choose these particular relative lengths because applicant has not disclosed that the dimensions are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical, and it appears prima facie that the product would possess utility using another dimension. Indeed, it has been held that mere dimensional limitations are prima facie obvious absent a disclosure that the limitations are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical. See, for example, *In re Rose*, 220 F.2d 459, 105 USPQ 237 (CCPA 1955); *In re Rinehart*, 531 F.2d 1048, 189 USPQ 143 (CCPA 1976); *Gardner v. TEC Systems, Inc.*, 725 F.2d 1338, 220 USPQ 777 (Fed. Cir. 1984), cert. denied, 469 U.S. 830, 225 USPQ 232 (1984); *In re Dailey*, 357 F.2d 669, 149 USPQ 47 (CCPA 1966).

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Further in the alternative, at column 6, lines 6-12, Haba teaches wherein the lengths of first, second and third bonding wires 440a, 440b, 440c, respectively, are approximately the same. In addition, it would have been obvious to combine the product of Haba with the product of Takiar, because it would provide desirable electrical properties.

Claims 24 and 27 are rejected under 35 U.S.C. 103(a) as being unpatentable over Takiar, or the combination of Takiar and Haba, as applied to claims 13, 14, 19-23, 25, 26 and 28 supra, and further in combination with Mathew (5328079).

As cited supra, Takiar teaches the following:

24. A multi-chip package type semiconductor device, as in 20, further comprising: a first wire 60, the first wire having one end connected to the second terminal and the other end connected to the second conductive portion.

27. A multi-chip package type semiconductor device, as in 25, further comprising: wherein the first wire is connected to the first area and the second wire is connected to the third conductive pattern.

However, Takiar does not appear to explicitly teach the particular bump connections.

Nevertheless, at column 3, line 1 to column 5, line 46, Mathew teaches the particular bump connections. Moreover, it

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would have been obvious to combine the product of Mathews with the product of Takiar because it would facilitate wire connection.

Claims 3-11, 12, 17 and 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Takiar, or the combination of Takiar and Haba, as applied to claims 13, 14, 19-23, 25, 26 and 28 supra, and further in combination with Mathew (5328079), or in the alternative, further in combination with Mathew and Hill (5091825).

As cited supra, Takiar teaches the following:

3. A multi-chip package type semiconductor device, as in 2, further comprising wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the second conductive pattern and the second bond as the ending connection of the second bonding wire is made at the first area, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the conductive relay pad in the second area and the second bond as the ending connection of the third bonding wire is made at the second terminal pad.

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4. A multi-chip package type semiconductor device, as in 2, further comprising, wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the conductive relay pad in the first area and the second bond as the ending connection of the second bonding wire is made at the second conductive pattern, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the second terminal pad and the second bond as the ending connection of the third bonding wire is made at the second area.

5. A multi-chip package type semiconductor device, as in 3, wherein the conductive relay pad is rectangularly-shaped [square], and is formed on the periphery of the first semiconductor chip, and a side of the rectangularly-shaped conductive relay pad is parallel to a side of the first semiconductor chip.

6. A multi-chip package type semiconductor device, as in 3, wherein the conductive relay pad is rectangularly-shaped, and is formed on the periphery of the first semiconductor chip, and a

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side of the rectangularly-shaped conductive relay pad is parallel to a side of the first semiconductor chip.

7. A multi-chip package type semiconductor device, as in 6, wherein the first area of the rectangularly-shaped conductive relay pad is closer to a side of the first semiconductor chip than the second area.

8. A multi-chip package type semiconductor device, as in 4, wherein the conductive relay pad is rectangularly-shaped, and is formed on the periphery of the first semiconductor chip, and a side of the rectangularly-shaped conductive relay pad is parallel to a side of the first semiconductor chip.

9. A multi-chip package type semiconductor device, as in 4, wherein the conductive relay pad is rectangularly-shaped, and is formed on the periphery of the first semiconductor chip, and a side of the rectangularly-shaped conductive relay pad is parallel to a side of the first semiconductor chip.

10. A multi-chip package type semiconductor device, as in 9, wherein the first area of the rectangularly-shaped conductive relay pad is closer to a side of the first semiconductor chip than the second area.

11. A multi-chip package type semiconductor device, as in 3, wherein the first area is not physically connected to the first bond of the third bonding wire, but is electrically

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connected to the first bond of the third bonding wire via the conductive relay pad.

12. A multi-chip package type semiconductor device, as in 4, wherein the second area is not physically connected to the first bond of the second bonding wire, but is electrically connected to the first bond of the second bonding wire via the conductive relay pad.

17. A multi-chip package type semiconductor device, as in 16, further comprising, wherein the first bond as the beginning connection of the first bonding wire is preformed at the first terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the second conductive pattern and the second bond as the ending connection of the second bonding wire is made at conductive relay pad, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the conductive relay pad and the second bond as the ending connection of the third bonding wire is made at the second terminal pad.

18. A multi-chip package type semiconductor device, as in 16, further comprising, wherein the first bond as the beginning connection of the first bonding wire is preformed at the first

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terminal pad and the second bond as the ending connection of the first bonding wire is made at the first conductive pattern, wherein the first bond as the beginning connection of the second bonding wire is preformed at the conductive pattern and the second bond as the ending connection of the second bonding wire is made at the conductive relay pad, and wherein the first bond as the beginning connection of the third bonding wire is preformed at the second terminal pad and the second bond as the ending connection of the third bonding wire is made at the conductive relay pad.

However, Takiar does not appear to explicitly teach the particular bump connections.

Nonetheless, as cited supra, Mathew teaches the particular bump connections, and Mathew is applied to the rejection for the same reason it was applied to the rejection of claims 24 and 27.

Also, although the combination of Takiar and Mathew does not appear to explicitly teach a longer and a shorter side of the rectangularly-shaped conductive relay pad, it would have been an obvious matter of design choice bounded by well known manufacturing constraints and ascertainable by routine experimentation and optimization to choose these particular dimensions because applicant has not disclosed that the dimensions are for a particular unobvious purpose, produce an

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unexpected result, or are otherwise critical, and it appears prima facie that the product would possess utility using another dimension. Indeed, it has been held that mere dimensional limitations are prima facie obvious absent a disclosure that the limitations are for a particular unobvious purpose, produce an unexpected result, or are otherwise critical. See, for example, *In re Rose*, 220 F.2d 459, 105 USPQ 237 (CCPA 1955); *In re Rinehart*, 531 F.2d 1048, 189 USPQ 143 (CCPA 1976); *Gardner v. TEC Systems, Inc.*, 725 F.2d 1338, 220 USPQ 777 (Fed. Cir. 1984), cert. denied, 469 U.S. 830, 225 USPQ 232 (1984); *In re Dailey*, 357 F.2d 669, 149 USPQ 47 (CCPA 1966).

In addition, it would be an inherent property of the product obtained by routine experimentation that each of the longer and the shorter sides would be parallel to a side of the first semiconductor chip.

In any case, in the alternative, at column 3, line 38 to column 4, line 10, hill teaches a longer and a shorter side of a rectangularly-shaped conductive bond pad 154a, each side parallel to a side of a first semiconductor chip 150. Moreover, it would have been obvious to combine the product of Hill with the product of Takiar because it would provide a pad.


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The art made of record and not applied to the rejection is considered pertinent to applicant's disclosure. It is cited primarily to show inventions similar to the instant invention.

Any telephone inquiry of a general nature or relating to the status (MPEP 203.08) of this application or proceeding should be directed to Group 2800 Customer Service whose telephone number is 703-306-3329.

Any telephone inquiry concerning this communication or earlier communications from the examiner should be directed to David E. Graybill at (703) 308-2947. Regular office hours: Monday through Friday, 8:30 a.m. to 6:00 p.m.

The fax phone number for group 2800 is 703/3087724.

A handwritten signature in black ink, appearing to read 'DEG', is positioned above the printed name of the examiner.

David E. Graybill
Primary Examiner
Art Unit 2827

D.G.
26-Sep-02